

**Search Notes**

Application/Control No.

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Examiner

Ellen Kim

Applicant(s)/Patent under  
Reexamination

FACCIO ET AL.

Art Unit

2874

**SEARCHED**

Class	Subclass	Date	Examiner
385	14,27	8/16/2007	EK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	8/16/2007	EK